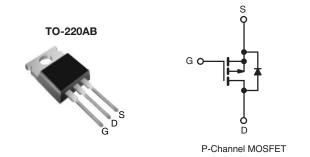


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 20	- 200			
R _{DS(on)} (Max.) (Ω)	V _{GS} = - 10 V	0.80			
Q _g (Max.) (nC)	29	29			
Q _{gs} (nC)	5.4	5.4			
Q _{gd} (nC)	15	15			
Configuration	Sing	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF9630PbF		
Lead (FD)-life	SiHF9630-E3		
SnPb	IRF9630		
SILD	SiHF9630		

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	- 200	V	
Gate-Source Voltage		V_{GS}	± 20]	
Continuous Drain Current	V_{GS} at - 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$		- 6.5	А	
Continuous Drain Current	$T_C = 100 ^{\circ}C$	ID	- 4.0		
Pulsed Drain Current ^a	I _{DM}	- 26			
Linear Derating Factor			0.59	W/°C	
Single Pulse Avalanche Energy ^b		E _{AS}	500	mJ	
Repetitive Avalanche Current ^a		I _{AR}	- 6.4	Α	
Repetitive Avalanche Energy ^a	E _{AR}	7.4	mJ		
Maximum Power Dissipation	ion $T_C = 25 ^{\circ}C$		74	W	
Peak Diode Recovery dV/dt ^c	dV/dt	- 5.0	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 OF IVIS SCIEW		1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 17 \,^{\circ}\text{mH}$, $R_q = 25 \,^{\circ}\Omega$, $I_{AS} = -6.5 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le -6.5 \text{ A}$, $dI/dt \le 120 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_{J} \le 150 \text{ °C}$.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7	

PARAMETER	SYMBOL	TEST	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	V, I _D = - 250 μA	- 200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = - 1 mA		-	- 0.24	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_0$	_{GS} , I _D = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	Vo	_{SS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 160 V, V _{GS} = 0 V, T _J = 125 °C		- 100 - 500	μA		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V		-	-	0.80	Ω
Forward Transconductance	9 _{fs}	V _{DS} = - 5	50 V, I _D = - 3.9 A ^b	2.8	-	-	S
Dynamic				ı	·		ı
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$		-	700	-	pF
Output Capacitance	C _{oss}			-	200	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0	MHz, see fig. 5	-	40	-	1
Total Gate Charge	Qg		I _D = - 6.5 A,	-	-	29	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$V_{DS} = -160 \text{ V},$	-	-	5.4	nC
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b	-	-	15	
Turn-On Delay Time	t _{d(on)}			-	12	_	
Rise Time	t _r	Van 1	00 V In 6 5 A	-	27	_	
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = -100 \text{ V}, I_D = -6.5 \text{ A},$ $V_{DD} = 15 \Omega, \text{ See fig. } 10^{\text{b}}$ Retween lead		-	28	_	ns
Fall Time	t _f			-	1		
Internal Drain Inductance	L _D			_	4.5	-	
Internal Source Inductance	Ls			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbo	MOSFET symbol showing the		-	- 6.5	^
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	- 26	A
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S	$_{S} = -6.5 \text{ A}, V_{GS} = 0 \text{ V}^{b}$	-	-	- 6.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 0F °C 1	6 F A dI/d+ 100 A/:-h	-	200	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}] IJ = 25 ⁻ U, IF = -	- 6.5 A, dl/dt = 100 A/μs ^b	-	1.9	2.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn	n-on time is negligible (turn	-on is do	minated b	y L _s and	L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

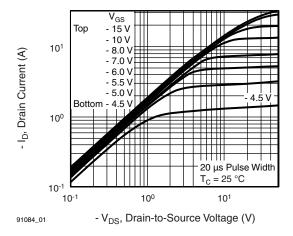


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

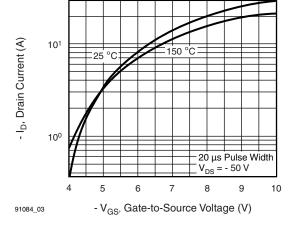


Fig. 3 - Typical Transfer Characteristics

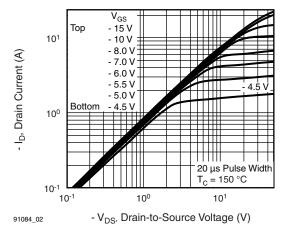


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

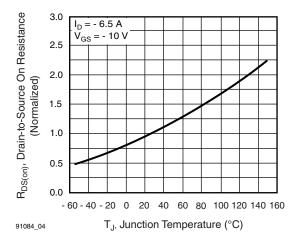


Fig. 4 - Normalized On-Resistance vs. Temperature



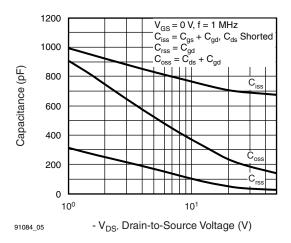


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

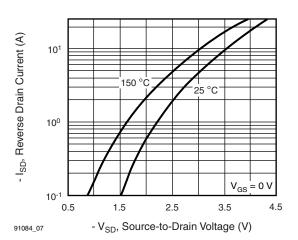


Fig. 7 - Typical Source-Drain Diode Forward Voltage

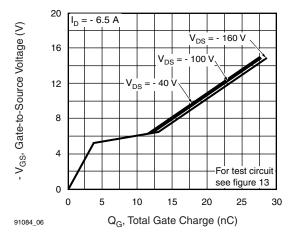


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

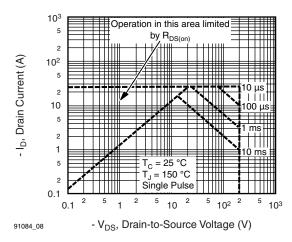


Fig. 8 - Maximum Safe Operating Area



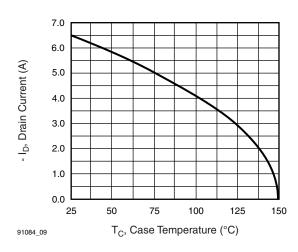


Fig. 9 - Maximum Drain Current vs. Case Temperature

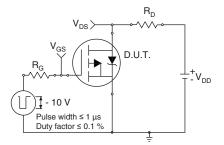


Fig. 10a - Switching Time Test Circuit

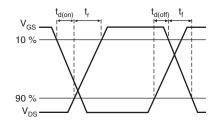


Fig. 10b - Switching Time Waveforms

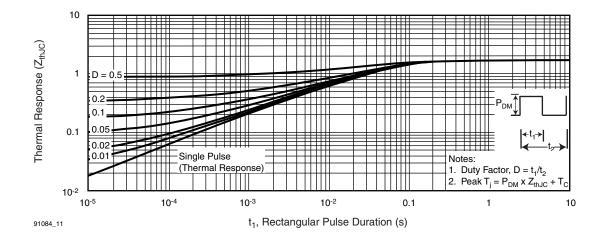


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



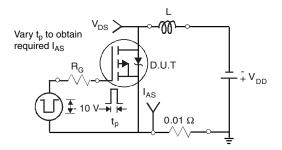


Fig. 12a - Unclamped Inductive Test Circuit

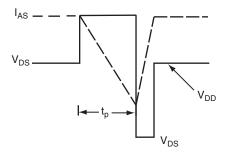


Fig. 12b - Unclamped Inductive Waveforms

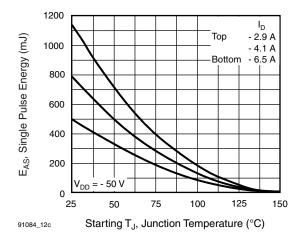


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

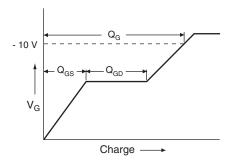


Fig. 13a - Basic Gate Charge Waveform

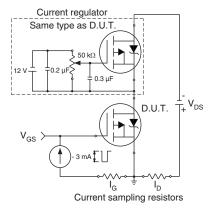
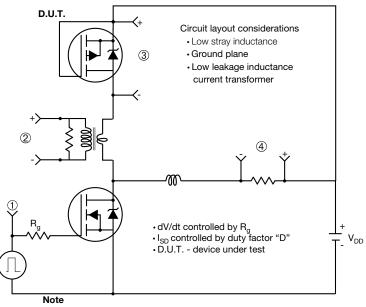


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

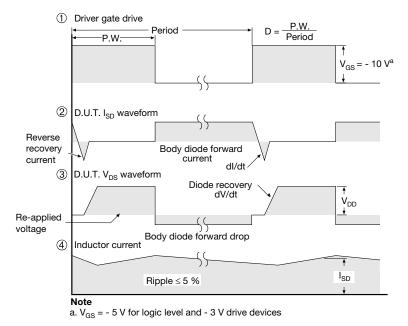
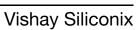


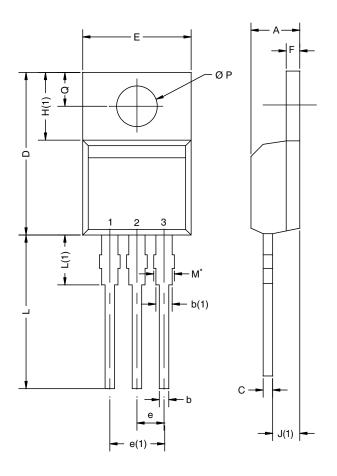
Fig. 14 - For P-Channel

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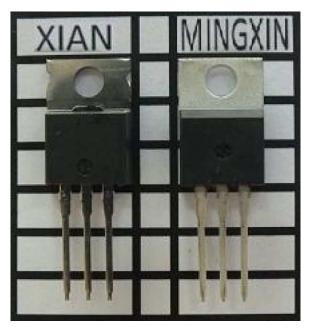
TO-220AB



DIM.	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	

Notes

- * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM
- Xi'an and Mingxin actual photo





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